

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1106-1064HAC01

Page 78 of 90

ANNEX F: CD1880V3 Dipole Calibration Certificate (SN: 1135)

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zaughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: **SCS 108**

Client **Auden**

Certificate No: **CD1880V3-1135_Jan10**

CALIBRATION CERTIFICATE																																																			
Object	CD1880V3 - SN: 1135																																																		
Calibration procedure(s)	QA CAL-20.v5 Calibration procedure for dipoles in air																																																		
Calibration date:	January 13, 2010																																																		
<p>This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.</p> <p>Calibration Equipment used (M&TE critical for calibration)</p> <table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th style="width: 30%;">Primary Standards</th> <th style="width: 15%;">ID #</th> <th style="width: 30%;">Cal Date (Certificate No.)</th> <th style="width: 25%;">Scheduled Calibration</th> </tr> </thead> <tbody> <tr> <td>Power meter EPM-442A</td> <td>GB37480704</td> <td>06-Oct-09 (No. 217-01086)</td> <td>Oct-10</td> </tr> <tr> <td>Power sensor HP 8481A</td> <td>US37292783</td> <td>06-Oct-09 (No. 217-01086)</td> <td>Oct-10</td> </tr> <tr> <td>Probe ER3DV6</td> <td>SN: 2336</td> <td>30-Dec-09 (No. ER3-2336_Dec09)</td> <td>Dec-10</td> </tr> <tr> <td>Probe H3DV6</td> <td>SN: 6065</td> <td>30-Dec-09 (No. H3-6065_Dec09)</td> <td>Dec-10</td> </tr> <tr> <td>DAE4</td> <td>SN: 781</td> <td>30-Nov-09 (No. DAE4-781_Nov09)</td> <td>Nov-10</td> </tr> </tbody> </table> <table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th style="width: 30%;">Secondary Standards</th> <th style="width: 15%;">ID #</th> <th style="width: 30%;">Check Date (in house)</th> <th style="width: 25%;">Scheduled Check</th> </tr> </thead> <tbody> <tr> <td>Power meter Agilent 4419B</td> <td>SN: GB42420181</td> <td>09-Oct-09 (in house check Oct-09)</td> <td>In house check: Oct-10</td> </tr> <tr> <td>Power sensor HP 8482H</td> <td>SN: 3318A09450</td> <td>09-Oct-09 (in house check Oct-09)</td> <td>In house check: Oct-10</td> </tr> <tr> <td>Power sensor HP 8482A</td> <td>SN: US37295597</td> <td>09-Oct-09 (in house check Oct-09)</td> <td>In house check: Oct-10</td> </tr> <tr> <td>Network Analyzer HP 8753E</td> <td>US37390585</td> <td>18-Oct-01 (in house check Oct-09)</td> <td>In house check: Oct-10</td> </tr> <tr> <td>RF generator E4433B</td> <td>MY 41000675</td> <td>03-Nov-04 (in house check Oct-09)</td> <td>In house check: Oct-11</td> </tr> </tbody> </table>				Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration	Power meter EPM-442A	GB37480704	06-Oct-09 (No. 217-01086)	Oct-10	Power sensor HP 8481A	US37292783	06-Oct-09 (No. 217-01086)	Oct-10	Probe ER3DV6	SN: 2336	30-Dec-09 (No. ER3-2336_Dec09)	Dec-10	Probe H3DV6	SN: 6065	30-Dec-09 (No. H3-6065_Dec09)	Dec-10	DAE4	SN: 781	30-Nov-09 (No. DAE4-781_Nov09)	Nov-10	Secondary Standards	ID #	Check Date (in house)	Scheduled Check	Power meter Agilent 4419B	SN: GB42420181	09-Oct-09 (in house check Oct-09)	In house check: Oct-10	Power sensor HP 8482H	SN: 3318A09450	09-Oct-09 (in house check Oct-09)	In house check: Oct-10	Power sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Oct-09)	In house check: Oct-10	Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-09)	In house check: Oct-10	RF generator E4433B	MY 41000675	03-Nov-04 (in house check Oct-09)	In house check: Oct-11
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Calibrated by:	Name Claudio Leubler	Function Laboratory Technician	Signature 																																																
Approved by:	Name Katja Pokovic	Technical Manager																																																	
Issued: January 19, 2010 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.																																																			

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Test Report

Report No. RZA1106-1064HAC01

Page 79 of 90

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Accreditation No.: **SCS 108**

References

- [1] ANSI-C63.19-2006
American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
- [2] ANSI-C63.19-2007
American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- **Coordinate System:** y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1, 2], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- **Measurement Conditions:** Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- **Antenna Positioning:** The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- **Feed Point Impedance and Return Loss:** These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminated by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- **E-field distribution:** E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1, 2], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- **H-field distribution:** H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

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Test Report

1. Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.2 B157
DASY PP Version	SEMCAD X	V14.0 B57
Phantom	HAC Test Arch	SD HAC P01 BA, #1070
Distance Dipole Top - Probe Center	10 mm	
Scan resolution	dx, dy = 5 mm	area = 20 x 90 mm
Frequency	1880 MHz ± 1 MHz	
Forward power at dipole connector	20.0 dBm = 100mW	
Input power drift	< 0.05 dB	

2. Maximum Field values

H-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured	100 mW forward power	0.475 A/m

Uncertainty for H-field measurement: 8.2% (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW forward power	142.9 V/m
Maximum measured above low end	100 mW forward power	139.7 V/m
Averaged maximum above arm	100 mW forward power	141.3 V/m

Uncertainty for E-field measurement: 12.8% (k=2)

3. Appendix

3.1 Antenna Parameters

Frequency	Return Loss	Impedance
1710 MHz	18.8 dB	(47.5 + j10.9) Ohm
1880 MHz	21.2 dB	(51.5 + j8.7) Ohm
1900 MHz	21.8 dB	(54.4 + j7.3) Ohm
1950 MHz	26.4 dB	(54.9 - j1.1) Ohm
2000 MHz	20.0 dB	(41.0 - j0.8) Ohm

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

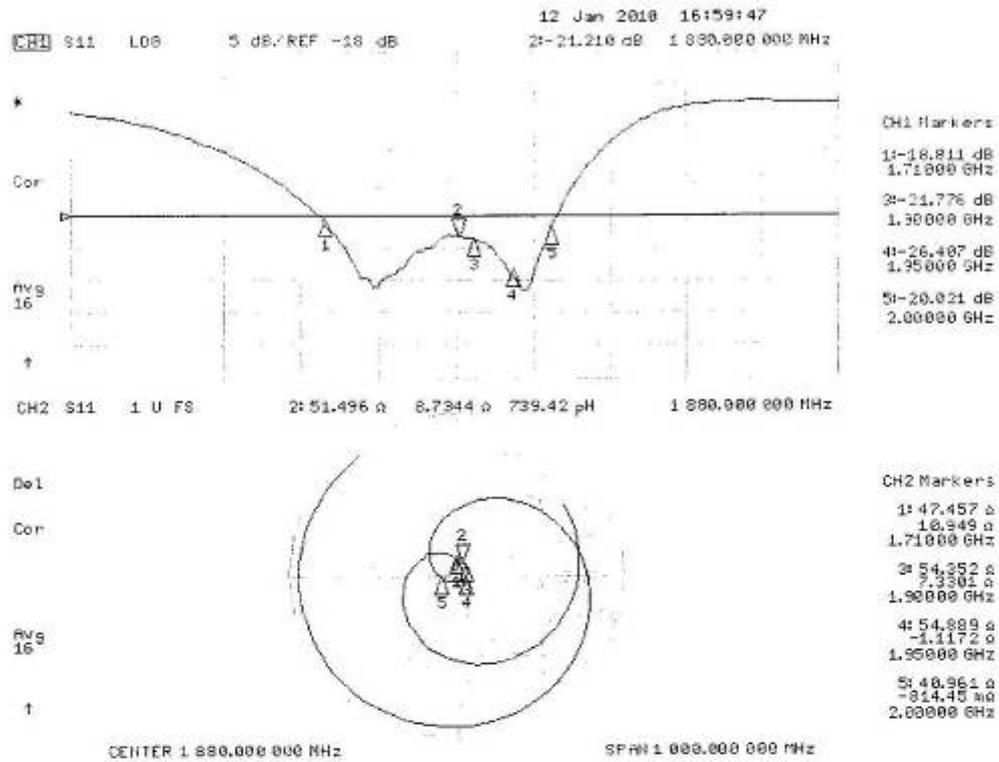
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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3.3 Measurement Sheets

3.3.1 Return Loss and Smith Chart



3.3.2 DASY4 H-Field Result

Date/Time: 13.01.2010 12:17:00

Test Laboratory: SPEAG Lab2

HAC_RF_CD1880_1135_100113_H_CL

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1135

Communication System: CW; Frequency: 1880 MHz

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: H3DV6 - SN6065; ; Calibrated: 30.12.2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 30.11.2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY5, V5.2 Build 157; SEMCAD X Version 14.0 Build 57

Dipole H-Field measurement @ 1880MHz/H Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.475 A/m

Probe Modulation Factor = 1

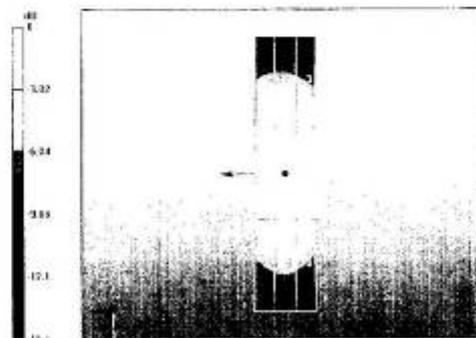
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.503 A/m; Power Drift = -0.017 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.421 M2	Grid 2 0.436 M2	Grid 3 0.410 M2
Grid 4 0.458 M2	Grid 5 0.475 M2	Grid 6 0.447 M2
Grid 7 0.412 M2	Grid 8 0.431 M2	Grid 9 0.407 M2



0 dB = 0.475A/m

3.3.3 DASY4 E-Field Result

Date/Time: 13.01.2010 13:42:51

Test Laboratory: SPEAG Lab2

HAC_RF_CD1880_1135_100113_E_CL

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1135

Communication System: CW; Frequency: 1880 MHz

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 30.12.2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 30.11.2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY5, V5.2 Build 157; SEMCAD X Version 14.0 Build 57

Dipole E-Field measurement @ 1880MHz/E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 142.9 V/m

Probe Modulation Factor = 1

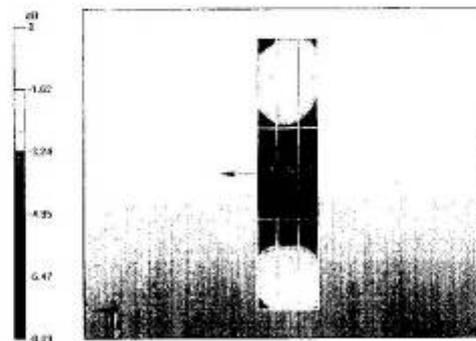
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 162.1 V/m; Power Drift = -0.010 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak E-field in V/m

Grid 1 136.2 M2	Grid 2 139.7 M2	Grid 3 135.5 M2
Grid 4 93.1 M3	Grid 5 95.1 M3	Grid 6 90.7 M3
Grid 7 135.2 M2	Grid 8 142.9 M2	Grid 9 140.6 M2



0 dB = 142.9V/m

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA1106-1064HAC01

Page 84 of 90

ANNEX G: DAE4 Calibration Certificate

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Accreditation No.: **SCS 108**

Client **TA - SH (Auden)**

Certificate No: **DAE4-871_Nov10**

CALIBRATION CERTIFICATE

Object **DAE4 - SD 000 D04 BJ - SN: 871**

Calibration procedure(s) **QA CAL-06.v22
Calibration procedure for the data acquisition electronics (DAE)**

Calibration date: **November 18, 2010**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	28-Sep-10 (No:10376)	Sep-11
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1004	07-Jun-10 (in house check)	In house check: Jun-11

Calibrated by:	Name Andrea Guntli	Function Technician	Signature
Approved by:	Name Fin Bornholt	Function R&D Director	Signature

Issued: November 18, 2010

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Test Report

Report No. RZA1106-1064HAC01

Page 85 of 90

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Accreditation No.: **SCS 108**

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
 - **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
 - **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
 - **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
 - **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - **Input resistance:** Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
 - **Power consumption:** Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV
Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.757 \pm 0.1% (k=2)	404.740 \pm 0.1% (k=2)	405.181 \pm 0.1% (k=2)
Low Range	3.98219 \pm 0.7% (k=2)	3.93489 \pm 0.7% (k=2)	3.96831 \pm 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	90.0 $^{\circ}$ \pm 1 $^{\circ}$
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Test Report

Appendix

1. DC Voltage Linearity

High Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	200001.2	-1.56	-0.00
Channel X + Input	20000.71	0.71	0.00
Channel X - Input	-19997.87	1.63	-0.01
Channel Y + Input	199994.3	1.99	0.00
Channel Y + Input	19998.92	-1.08	-0.01
Channel Y - Input	-20000.26	-0.76	0.00
Channel Z + Input	200009.2	-1.04	-0.00
Channel Z + Input	19998.70	-1.10	-0.01
Channel Z - Input	-20000.16	-0.76	0.00

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	2000.1	0.16	0.01
Channel X + Input	199.58	-0.52	-0.26
Channel X - Input	-200.79	-0.89	0.45
Channel Y + Input	1999.9	-0.03	-0.00
Channel Y + Input	199.45	-0.55	-0.27
Channel Y - Input	-200.31	-0.41	0.21
Channel Z + Input	2000.1	0.33	0.02
Channel Z + Input	199.13	-0.77	-0.38
Channel Z - Input	-201.47	-1.37	0.69

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	14.25	12.86
	-200	-12.68	-14.21
Channel Y	200	-10.04	-10.39
	-200	9.20	9.17
Channel Z	200	-0.85	-1.40
	-200	-0.34	-0.31

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	2.85	0.69
Channel Y	200	2.41	-	2.73
Channel Z	200	2.54	0.73	-

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15920	15517
Channel Y	16171	16732
Channel Z	15803	16474

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.03	-2.35	0.86	0.43
Channel Y	-0.50	-1.49	-0.49	0.38
Channel Z	-0.92	-2.21	0.14	0.44

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9